

LTC5592

FEATURES

- Conversion Gain: 8.3dB at 2.35GHz
- IIP3: 27.3dBm at 2.35GHz
- Noise Figure: 9.8dB at 2.35GHz
- 15.3dB NF Under 5dBm Blocking
- High Input P1dB
- 47dB Channel-to-Channel Isolation
- **3.3V Supply, 1.3W Power Consumption**
- Low Power Mode for 0.8W Consumption
- Independent Channel Shutdown Control
- **50**Ω Single-Ended RF and LO Inputs
- LO Input Matched In All Modes
- OdBm LO Drive Level
- Small Package and Solution Size
- –40°C to 105°C Operation

APPLICATIONS

- 3G/4G Wireless Infrastructure Diversity Receivers (LTE, W-CDMA, TD-SCDMA, WiMAX, GSM 1800)
- MIMO Infrastructure Diversity Receivers
- High Dynamic Range Downmixer Applications

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TYPICAL APPLICATION



Dual 1.6GHz to 2.7GHz High Dynamic Range Downconverting Mixer DESCRIPTION

The LTC[®]5592 is part of a family of dual-channel high dynamic range, high gain downconverting mixers covering the 600MHz to 4.5GHz RF frequency range. The LTC5592 is optimized for 1.6GHz to 2.7GHz RF applications. The LO frequency must fall within the 1.5GHz to 2.5GHz range for optimum performance. A typical application is a LTE or WiMAX receiver with a 2.3GHz to 2.7GHz RF input and low side LO.

The LTC5592's high conversion gain and high dynamic range enable the use of lossy IF filters in high selectivity receiver designs, while minimizing the total solution cost, board space and system-level variation. A low current mode is provided for additional power savings and each of the mixer channels has independent shutdown control.

High Dynamic Range Dual Downconverting Mixer Family

	,
RF RANGE	LO RANGE
600MHz to 1.7GHz	700MHz to 1.5GHz
1.3GHz to 2.3GHz	1.4GHz to 2.1GHz
1.6GHz to 2.7GHz	1.5GHz to 2.5GHz
2.3GHz to 4.5GHz	2.1GHz to 4.2GHz
	600MHz to 1.7GHz 1.3GHz to 2.3GHz 1.6GHz to 2.7GHz

Wideband Conversion Gain and IIP3 vs IF Frequency



LTC5592 ONLY, MEASURED ON EVALUATION BOARD

ABSOLUTE MAXIMUM RATINGS

(Note 1)

Supply Voltage (V_{CC})
Enable Voltage (ENA, ENB)–0.3V to V_{CC} + 0.3V Bias Adjust Voltage (IFBA, IFBB)–0.3V to V_{CC} + 0.3V
Power Select Voltage (I_{SEL})0.3V to V _{CC} + 0.3V
LO Input Power (1GHz to 3GHz)9dBm
LO Input DC Voltage±0.1V
RFA, RFB Input Power (1GHz to 3GHz)15dBm
RFA, RFB Input DC Voltage ±0.1V
Operating Temperature Range $(T_{\rm C})$ 40°C to 105°C
Storage Temperature Range65°C to 150°C
Junction Temperature (T _J) 150°C

PIN CONFIGURATION



ORDER INFORMATION

LEAD FREE FINISH	TAPE AND REEL	PART MARKING	PACKAGE DESCRIPTION	TEMPERATURE RANGE
LTC5592IUH#PBF	LTC5592IUH#TRPBF	5592	24-Lead (5mm × 5mm) Plastic QFN	-40°C to 105°C

Consult LTC Marketing for parts specified with wider operating temperature ranges. Consult LTC Marketing for information on non-standard lead based finish parts.

For more information on lead free part marking, go to: http://www.linear.com/leadfree/

For more information on tape and reel specifications, go to: http://www.linear.com/tapeandreel/

DC ELECTRICAL CHARACTERISTICS

unless otherwise noted. Test circuit shown in Figure 1. (Note 2)

 V_{CC} = 3.3V, V_{CCIF} = 3.3V, ENA = ENB = High, I_{SEL} = Low, T_C = 25°C,

CONDITIONS	MIN	TYP	MAX	UNITS
IFB)	1			
	3.1	3.3	3.5	V
	3.1	3.3	5.3	V
Both Channels Enabled		199	237	mA
Both Channels Enabled		202	252	mA
Both Channels Enabled		401	489	mA
ENA = ENB = Low			500	μA
· · · · ·	·			
	2.5			V
			0.3	V
-0.3V to V _{CC} + 0.3V	-20		30	μA
		0.9		μs
		1		μs
	IFB) Both Channels Enabled Both Channels Enabled Both Channels Enabled ENA = ENB = Low	IFB) IFB) IFB) String Strin	IFB) 3.1 3.3 Both Channels Enabled 199 Both Channels Enabled 202 Both Channels Enabled 401 ENA = ENB = Low 2.5 -0.3V to V _{CC} + 0.3V -20	IFB) 3.1 3.3 3.5 Both Channels Enabled 199 237 Both Channels Enabled 202 252 Both Channels Enabled 401 489 ENA = ENB = Low 500 2.5 0.3 $-0.3V$ to $V_{CC} + 0.3V$



DC ELECTRICAL CHARACTERISTICS

unless otherwise noted. Test circuit shown in Figure 1. (Note 2)

 V_{CC} = 3.3V, V_{CCIF} = 3.3V, ENA = ENB = High, I_{SEL} = Low, T_C = 25°C,

PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS
Low Power Mode Logic Input (I _{SEL}) High = Low Power	, Low = Normal Power Mode	·			
I _{SEL} Input High Voltage		2.5			V
I _{SEL} Input Low Voltage				0.3	V
I _{SEL} Input Current	-0.3V to V _{CC} + 0.3V	-20		30	μA
Low Power Mode Current Consumption (I _{SEL} = High)					
Mixer Supply Current (Pins 12, 19)	Both Channels Enabled		130	156	mA
IF Amplifier Supply Current (Pins 9, 10, 21, 22)	Both Channels Enabled		122	156	mA
Total Supply Current (Pins 9, 10, 12, 19, 21, 22)	Both Channels Enabled		252	312	mA

AC ELECTRICAL CHARACTERISTICS $V_{CC} = 3.3V$, $V_{CCIF} = 3.3V$, ENA = ENB = High, $I_{SEL} = Low$, $T_C = 25^{\circ}C$, $P_{L0} = 0dBm$, $P_{RF} = -3dBm$ ($\Delta f = 2MHz$ for two tone IIP3 tests), unless otherwise noted. Test circuit shown in Figure 1. (Notes 2, 3, 4)

PARAMETER	CONDITIONS	MIN TYP MAX	UNITS
LO Input Frequency Range		1500 to 2500	MHz
RF Input Frequency Range	Low Side LO High Side LO	1600 to 2700 1600 to 2300	MHz MHz
IF Output Frequency Range	Requires External Matching	5 to 500	MHz
RF Input Return Loss	$Z_0 = 50\Omega$, 1600MHz to 2700MHz	>13	dB
LO Input Return Loss	Z ₀ = 50Ω, 1700MHz to 2500MHz	>17	dB
IF Output Impedance	Differential at 190MHz	379Ω 2.2pF	R C
LO Input Power	f _{L0} = 1700MHz to 2500MHz	-4 0 6	dBm
LO to RF Leakage	f _{L0} = 1700MHz to 2500MHz	<-34	dBm
LO to IF Leakage	f _{L0} = 1700MHz to 2500MHz	<-37	
RF to LO Isolation	f _{RF} = 1600MHz to 2700MHz	>57	dB
RF to IF Isolation	f _{RF} = 1600MHz to 2700MHz	>37	dB
Channel-to-Channel Isolation	f _{RF} = 1600MHz to 2700MHz	>47	dB

Low Side LO Downmixer Application: I_{SEL} = Low, RF = 1900MHz to 2700MHz, IF = 190MHz, f_{LO} = $f_{RF} - f_{IF}$

PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS
Conversion Gain	RF = 1950MHz RF = 2350MHz RF = 2550MHz	6.8	9.5 8.3 8.1		dB dB dB
Conversion Gain Flatness	RF = 2350 ±30MHz, LO = 2160MHz, IF = 190 ±30MHz		±0.14		dB
Conversion Gain vs Temperature	T _C = -40°C to 105°C, RF = 2350MHz		-0.006		dB/°C
Input 3rd Order Intercept	RF = 1950MHz RF = 2350MHz RF = 2550MHz	24.0	26.3 27.3 26.3		dBm dBm dBm
SSB Noise Figure	RF = 1950MHz RF = 2350MHz RF = 2550MHz		9.4 9.8 9.9		dB dB dB



$\begin{array}{l} \textbf{AC ELECTRICAL CHARACTERISTICS} \\ \textbf{P}_{RF} = -3dBm \ (\Delta f = 2MHz \ for \ two \ tone \ IIP3 \ tests), \ unless \ otherwise \ noted. \ Test \ circuit \ shown \ in \ Figure \ 1. \ (Notes \ 2, \ 3) \end{array}$

Low Side LO Downmixer Application: I	_{EL} = Low, RF = 1900MHz to 2700MHz,	$IF = 190MHz, f_{LO} = f_{RF} - f_{IF}$
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PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS
SSB Noise Figure Under Blocking	f_{RF} = 2400MHz, f_{LO} = 2210MHz, f_{BLOCK} = 2500MHz P_{BLOCK} = 5dBm P_{BLOCK} = 10dBm		15.3 21.2		dB dB
2RF-2LO Output Spurious Product $(f_{RF} = f_{LO} + f_{IF}/2)$	f_{RF} = 2255MHz at -10dBm, f_{LO} = 2160MHz, f_{IF} = 190MHz		-68		dBc
3RF-3LO Output Spurious Product $(f_{RF} = f_{LO} + f_{IF}/3)$	f _{RF} = 2223.33MHz at –10dBm, f _{LO} = 2160MHz, f _{IF} = 190MHz		-74		dBc
Input 1dB Compression	f_{RF} = 2350MHz, V _{CCIF} = 3.3V f_{RF} = 2350MHz, V _{CCIF} = 5V		11 14.6		dBm dBm

Low Power Mode, Low Side LO Downmixer Application: I_{SEL} = High, RF = 1900MHz to 2700MHz, IF = 190MHz, f_{LO} = f_{RF} – f_{IF}

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
	CONDITIONS	IVIIIN		IVIAA	UNITS
Conversion Gain	RF = 2350MHz		7.1		dB
Input 3rd Order Intercept	RF = 2350MHz		22.3		dBm
SSB Noise Figure	RF = 2350MHz		10.2		dB
Input 1dB Compression	RF = 2350MHz, V _{CCIF} = 3.3V RF = 2350MHz, V _{CCIF} = 5V		11.3 12.6		dBm dBm

High Side LO Downmixer Application: I_{SEL} = Low, RF = 1600MHz to 2300MHz, IF = 190MHz, f_{LO} = f_{RF} + f_{IF}

PARAMETER	CONDITIONS	MIN TYP	MAX	UNITS
Conversion Gain	RF = 1750MHz RF = 1950MHz RF = 2150MHz	9.1 8.7 8.3		dB dB dB
Conversion Gain Flatness	RF = 1950 ±30MHz, LO = 2140MHz, IF = 190 ±30MHz	±0.33		dB
Conversion Gain vs Temperature	$T_{\rm C} = -40^{\circ}$ C to 105°C, RF = 1900MHz	-0.005		dB/°C
Input 3rd Order Intercept	RF = 1750MHz RF = 1950MHz RF = 2150MHz	25.3 25.4 25.1		dBm dBm dBm
SSB Noise Figure	RF = 1750MHz RF = 1950MHz RF = 2150MHz	9.2 9.8 10.4		dB dB dB
SSB Noise Figure Under Blocking	$ \begin{array}{l} f_{RF} = 1950 MHz, f_{LO} = 2140 MHz, f_{BLOCK} = 1850 MHz \\ P_{BLOCK} = 5dBm \\ P_{BLOCK} = 10dBm \end{array} $	$P_{BLOCK} = 5dBm$ 16.5		dB dB
2L0-2RF Output Spurious Product $(f_{RF} = f_{L0} - f_{IF}/2)$	f_{RF} = 2045MHz at -10dBm, f_{LO} = 2140MHz, f_{IF} = 190MHz			dBc
3LO-3RF Output Spurious Product $(f_{RF} = f_{LO} - f_{IF}/3)$	$f_{RF} = 2076.67 MHz at -10 dBm, f_{LO} = 2140 MHz, f_{IF} = 190 MHz$	-75		dBc
Input 1dB Compression	RF = 1950MHz, V _{CCIF} = 3.3V RF = 1950MHz, V _{CCIF} = 5V	10.6 14.0		dBm dBm

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 3: SSB Noise Figure measured with a small-signal noise source, bandpass filter and 6dB matching pad on RF input, bandpass filter and 6dB matching pad on the LO input, and no other RF signals applied.

Note 2: The LTC5592 is guaranteed functional over the case operating temperature range of -40° C to 105° C ($\theta_{JC} = 7^{\circ}$ C/W).

Note 4: Channel A to channel B isolation is measured as the relative IF output power of channel B to channel A, with the RF input signal applied to channel A. The RF input of channel B is 50Ω terminated and both mixers are enabled.





TYPICAL AC PERFORMANCE CHARACTERISTICS Low Side LO

 $V_{CC} = 3.3V$, $V_{CCIF} = 3.3V$, ENA = ENB = High, $I_{SEL} = Low$, $T_C = 25^{\circ}C$, $P_{LO} = 0dBm$, $P_{RF} = -3dBm$ (-3dBm/tone for two-tone IIP3 tests, $\Delta f = 2MHz$), IF = 190MHz, unless otherwise noted. Test circuit shown in Figure 1.







TYPICAL AC PERFORMANCE CHARACTERISTICS Low Side LO

 $V_{CC} = 3.3V$, $V_{CCIF} = 3.3V$, ENA = ENB = High, $I_{SEL} = Low$, $T_C = 25^{\circ}C$, $P_{LO} = 0dBm$, $P_{RF} = -3dBm$ (-3dBm/tone for two-tone IIP3 tests, $\Delta f = 2MHz$), IF = 190MHz, unless otherwise noted. Test circuit shown in Figure 1.





2 × 2 and 3 × 3 Spur Suppression vs LO Input Power









RF Isolation vs **RF** Frequency





IIP3 Distribution



SSB Noise Figure Distribution



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Low Power Mode, Low Side LO

TYPICAL AC PERFORMANCE CHARACTERISTICS

 $V_{CC} = 3.3V$, $V_{CCIF} = 3.3V$, ENA = ENB = High, $I_{SEL} =$ High, $T_C = 25^{\circ}C$, $P_{LO} = 0dBm$, $P_{RF} = -3dBm$ (-3dBm/tone for two-tone IIP3 tests, $\Delta f = 2MHz$), IF = 190MHz, unless otherwise noted. Test circuit shown in Figure 1.





5592 G25

5592 626

TYPICAL AC PERFORMANCE CHARACTERISTICS High Side LO

 $V_{CC} = 3.3V$, $V_{CCIF} = 3.3V$, ENA = ENB = High, $I_{SEL} = Low$, $T_C = 25^{\circ}C$, $P_{LO} = 0dBm$, $P_{RF} = -3dBm$ (-3dBm/tone for two-tone IIP3 tests, $\Delta f = 2MHz$), IF = 190MHz, unless otherwise noted. Test circuit shown in Figure 1.





5592 G35

5592 G34



5592 G36

TYPICAL DC PERFORMANCE CHARACTERISTICS

 I_{SEL} = Low, ENA = ENB = High, test circuit shown in Figure 1.



PIN FUNCTIONS

RFA, **RFB** (**Pins 1, 6**): Single-Ended RF Inputs for Channels A and B. These pins are internally connected to the primary sides of the RF input transformers, which have low DC resistance to ground. **Series DC-blocking capacitors should be used to avoid damage to the integrated transformer when DC voltage is present at the RF inputs. The RF inputs are impedance matched when the LO input is driven with a 0±6dBm source between 1.5GHz and 2.5GHz and the channels are enabled.** **CTA, CTB (Pins 2, 5):** RF Transformer Secondary Center-Tap on Channels A and B. These pins may require bypass capacitors to ground to optimize IIP3 performance. Each pin has an internally generated bias voltage of 1.2V and must be DC-isolated from ground and V_{CC} .

GND (Pins 3, 4, 7, 13, 15, 24, Exposed Pad Pin 25): Ground. These pins must be soldered to the RF ground plane on the circuit board. The exposed pad metal of the package provides both electrical contact to ground and good thermal contact to the printed circuit board.





PIN FUNCTIONS

IFGNDB, IFGNDA (Pins 8, 23): DC Ground Returns for the IF Amplifiers. These pins must be connected to ground to complete the DC current paths for the IF amplifiers. Chip inductors may be used to tune LO-IF and RF-IF leakage. Typical DC current is 101mA for each pin.

IFB+, **IFB⁻**, **IFA⁻**, **IFA+** (**Pins 9**, **10**, **21**, **22**): Open-Collector Differential Outputs for the IF Amplifiers of Channels B and A. These pins must be connected to a DC supply through impedance matching inductors, or transformer center-taps. Typical DC current consumption is 50.5mA into each pin.

IFBB, IFBA (Pins 11, 20): Bias Adjust Pins for the IF Amplifiers. These pins allow independent adjustment of the internal IF buffer currents for channels B and A, respectively. The typical DC voltage on these pins is 2.2V. If not used, these pins must be DC isolated from ground and V_{CC} .

 V_{CCB} and V_{CCA} (Pins 12, 19): Power Supply Pins for the LO Buffers and Bias Circuits. These pins must be connected to a regulated 3.3V supply with bypass capacitors located close to the pins. Typical current consumption is 99.5mA per pin.

ENB, ENA (Pins 14, 17): Enable Pins. These pins allow Channels B and A, respectively, to be independently enabled. An applied voltage of greater than 2.5V activates the associated channel while a voltage of less than 0.3V disables the channel. Typical input current is less than 10μ A. These pins must not be allowed to float.

LO (Pin 16): Single-Ended Local Oscillator Input. This pin is internally connected to the primary side of the LO input transformer and has a low DC resistance to ground. **Series DC-blocking capacitors should be used to avoid damage to the integrated transformer when DC voltage present at LO input.** The LO input is internally matched to 50Ω for all states of ENA and ENB.

I_{SEL} (Pin 18): Low Power Select Pin. When this pin is pulled low (<0.3V), both mixer channels are biased at the normal current level for best RF performance. When greater than 2.5V is applied, both channels operate at reduced current, which provides reasonable performance at lower power consumption. This pin must not be allowed to float.

BLOCK DIAGRAM





TEST CIRCUIT



LI, LZ VS II I	NEQUENCIES
IF (MHz)	L1, L2 (nH)
140	270
190	150
240	100
300	56
380	33
450	22

REF DES	VALUE	SIZE	VENDOR
C1A, C1B	22pF	0402	AVX
C2	2.2pF	0402	AVX
C3A, C3B C5A, C5B	22pF	0402	AVX
C4, C6	1µF	0603	AVX
C7A, C7B	1000pF	0402	AVX
C8A, C8B	4.7pF	0402	AVX
L1A, L1B L2A, L2B	150nH	0603	Coilcraft
T1A, T1B	TC4-1W-7ALN+		Mini-Circuits





Introduction

The LTC5592 consists of two identical mixer channels driven by a common LO input signal. Each high linearity mixer consists of a passive double-balanced mixer core, IF buffer amplifier, LO buffer amplifier and bias/enable circuits. See the Pin Functions and Block Diagram sections for a description of each pin. Each of the mixers can be shutdown independently to reduce power consumption and low current mode can be selected that allows a trade-off between performance and power consumption. The RF and LO inputs are single-ended and are internally matched to 50Ω . Low side or high side LO injection can be used. The IF outputs are differential. The evaluation circuit, shown in Figure 1, utilizes bandpass IF output matching and an IF transformer to realize a 50Ω single-ended IF output. The evaluation board layout is shown in Figure 2.



Figure 2. Evaluation Board Layout (DC1710A)

RF Inputs

The RF inputs of channels A and B are identical. The RF input of channel A, shown in Figure 3, is connected to the primary winding of an integrated transformer. A 50Ω match is realized when a series external capacitor, C1A, is connected to the RF input. C1A is also needed for DC blocking if the source has DC voltage present, since the primary side of the RF transformer is internally DC-grounded. The DC resistance of the primary is approximately 3.9Ω .

The secondary winding of the RF transformer is internally connected to the channel A passive mixer core. The center-tap of the transformer secondary is connected to Pin 2 (CTA) to allow the connection of bypass capacitor, C8A. The value of C8A can be adjusted to improve channel isolation at specific RF frequencies with minor impact to conversion gain, linearity and noise performance. When used, it should be located within 2mm of Pin 2 for proper high frequency decoupling. The nominal DC voltage on the CTA pin is 1.2V.

For the RF inputs to be properly matched, the appropriate LO signal must be applied to the LO input. A broadband input match is realized with C1A = 22pF. The measured input return loss is shown in Figure 4 for LO frequencies of 1.7GHz, 2.16GHz and 2.5GHz. As shown in Figure 4, the RF input impedance is dependent on LO frequency, although a single value of C1A is adequate to cover the 1.7GHz to 2.5GHz RF band.



Figure 3. Channel A RF Input Schematic



The RF input impedance and input reflection coefficient, versus RF frequency, are listed in Table 1. The reference plane for this data is Pin 1 of the IC, with no external matching, and the LO is driven at 2.16GHz.

FREQUENCY	RF INPUT	- <u>L</u> 0	11
		3	11
(GHz)	IMPEDANCE	MAG	ANGLE
1.6	66.0 + j6.8	0.15	20
1.7	62.4 + j0.5	0.11	2
1.8	57.9 – j3.8	0.08	-24
1.9	53.2 – j6.1	0.07	-59
2.0	48.5 – j8.8	0.09	-95
2.1	40.6 – j9.3	0.14	-130
2.2	35.0 – j0.1	0.18	-180
2.3	39.3 + j3.7	0.13	-201
2.4	41.2 + j3.9	0.11	-207
2.5	41.7 + j4.3	0.10	-211
2.6	42.8 + j4.1	0.09	-212
2.7	44.1 + j3.6	0.07	-213

Table 1. RF Input Impedance and S11	
(at Pin 1, No External Matching, $f_{L0} = 2.16GHz$)	



Figure 5. LO Input Schematic

LO Input

The LO input, shown in Figure 5, is connected to the primary winding of an integrated transformer. A 50Ω impedance match is realized at the LO port by adding an external series capacitor, C2. This capacitor is also needed for DC blocking if the LO source has DC voltage present, since the primary side of the LO transformer is DC-grounded internally. The DC resistance of the primary is approximately 1.8Ω .

The secondary of the transformer drives a pair of high speed limiting differential amplifiers for channels A and B. The LTC5592's LO amplifiers are optimized for the 1.7GHz to 2.5GHz LO frequency range; however, LO frequencies outside this frequency range may be used with degraded performance.

The LO port is always 50Ω matched when V_{CC} is applied, even when one or both of the channels is disabled. This helps to reduce frequency pulling of the LO source when the mixer is switched between different operating states. Figure 6 illustrates the LO port return loss for the different operating modes.



The nominal LO input level is 0dBm, though the limiting amplifiers will deliver excellent performance over a ±6dBm input power range. Table 2 lists the LO input impedance and input reflection coefficient versus frequency.

Table 2. LO Input Impedance vs Frequency (at Pin 16, No External Matching, ENA = ENB = High)

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FREQUENCY	INPUT	S1	1	
(GHz)	IMPEDANCE	MAG	ANGLE	
1.7	46.4 + j34.4	0.34	76	
1.8	47.0 + j31.0	0.31	78	
1.9	46.5 + J28.2	0.28	81	
2.0	44.4 + J26.8	0.28	86	
2.1	43.1 + j26.0	0.28	89	
2.2	41.8 + j26.2	0.29	91	
2.3	40.4 + j27.4	0.31	92	
2.4	38.8 + j28.5	0.33	94	
2.5	38.0 + j30.4	0.35	93	



IF Outputs

The IF amplifiers in channels A and B are identical. The IF amplifier for channel A, shown in Figure 7, has differential open collector outputs (IFA⁺ and IFA⁻), a DC ground return pin (IFGNDA), and a pin for adjusting the internal bias (IFBA). The IF outputs must be biased at the supply voltage (V_{CCIFA}), which is applied through matching inductors L1A and L2A. Alternatively, the IF outputs can be biased through the center tap of a transformer (T1A). The common node of L1A and L2A can be connected to the center tap of the transformer. Each IF output pin draws approximately 50.5mA of DC supply current (101mA total). An external load resistor, R2A, can be used to improve impedance matching if desired.

IFGNDA (Pin 23) must be grounded or the amplifier will not draw DC current. Inductor L3A may improve LO-IF and RF-IF leakage performance in some applications, but is otherwise not necessary. Inductors should have small resistance for DC. High DC resistance in L3A will reduce the IF amplifier supply current, which will degrade RF performance.



Figure 7. IF Amplifier Schematic with Bandpass Match

For optimum single-ended performance, the differential IF output must be combined through an external IF transformer or a discrete IF balun circuit. The evaluation board (see Figures 1 and 2) uses a 4:1 IF transformer for impedance transformation and differential to single-ended conversion. It is also possible to eliminate the IF transformer and drive differential filters or amplifiers directly.

The IF output impedance can be modeled as 379Ω in parallel with 2.2pF. The equivalent small-signal model, including bondwire inductance, is shown in Figure 8. Frequency-dependent differential IF output impedance is listed in Table 3. This data is referenced to the package pins (with no external components) and includes the effects of IC and package parasitics.



Figure 8. IF Output Small-Signal Model

Bandpass IF Matching

The bandpass IF matching configuration, shown in Figures 1 and 7, is best suited for IF frequencies in the 90MHz to 500MHz range. Resistor R2A may be used to reduce the IF output resistance for greater bandwidth and inductors L1A and L2A resonate with the internal IF output capacitance at the desired IF frequency. The value of L1A, L2A can be estimated as follows:

$$L1A = L2A = \frac{1}{\left[\left(2\pi f_{\mathsf{IF}}\right)^2 \bullet 2 \bullet C_{\mathsf{IF}}\right]}$$

where C_{IF} is the internal IF capacitance (listed in Table 3).

Values of L1A and L2A are tabulated in Figure 1 for various IF frequencies. The measured IF output return loss for bandpass IF matching is plotted in Figure 9.

DIFFERENTIAL OUTPUT IMPEDANCE (R _{IF} X _{IF} (C _{IF}))
403 - j610 (2.9pF)
384 – j474 (2.4pF)
379 – j381 (2.2pF)
380 – j316 (2.1pF)
377 – j253 (2.1pF)
376 – j210 (2.0pF)
360 – j177 (2.0pF)

Table 3. IF Output Impedance vs Frequency



Figure 9. IF Output Return Loss with Bandpass Matching

Lowpass IF Matching

For IF frequencies below 90MHz, the inductance values become unreasonably high and the lowpass topology shown in Figure 10 is preferred. This topology also can provide improved RF to IF and LO to IF isolation. V_{CCIFA} is supplied through the center tap of the 4:1 transformer. A lowpass impedance transformation is realized by shunt elements R2A and C9A (in parallel with the internal RIF and CIF), and series inductors L1A and L2A. Resistor R2A is used to reduce the IF output resistance for greater bandwidth, or it can be omitted for the highest conversion gain. The final impedance transformation to 50Ω is realized by transformer T1A. The measured return loss is shown in Figure 11 for different values of inductance (C9A = open). The case with 82nH inductors and a 1k load resistor (R2A) is also shown. The LTC5592 demo



Figure 10. IF Output with Lowpass Matching



Figure 11. IF Output Return Loss with Lowpass Matching

board (see Figure 2) has been laid out to accommodate this matching topology with only minor modifications.

IF Amplifier Bias

The IF amplifier delivers excellent performance with V_{CCIF} = 3.3V, which allows a single supply to be used for V_{CC} and V_{CCIF} . At V_{CCIF} = 3.3V, the RF input P1dB of the mixer is limited by the output voltage swing. For higher P1dB, in this case, resistor R2A (Figure 7) can be used to reduce the output impedance and thus the voltage swing, thus improving P1dB. The trade-off for improved P1dB will be lower conversion gain.

With V_{CCIF} increased to 5V the P1dB increases by over 3dB, at the expense of higher power consumption. Mixer P1dB performance at 1950MHz and 2350MHz is tabulated in Table 4 for V_{CCIF} values of 3.3V and 5V. For the highest conversion gain, high-Q wire-wound chip inductors are recommended for L1A and L2A. Low cost multilayer chip inductors may be substituted, with a slight reduction in conversion gain.



Table 4. Performance Comparison with $V_{CCIF} = 3.3V$ and 5V

(RF = 1950	(RF = 1950MHz, High Side LO, IF = 190MHz)						
V _{CCIF} (V)	R2A (Ω)	I _{CCIF} (mA)	G _C (dB)	P1dB (dBm)	IIP3 (dBm)	NF (dB)	
3.3	Open	202	8.7	10.6	25.4	9.8	
	1k	202	7.5	11.3	25.4	9.9	
5	Open	209	8.7	14.0	25.5	9.9	

(RF = 2350MHz, Low Side LO, IF = 190MHz)

V _{CCIF} (V)	R2A (Ω)	I _{CCIF} (mA)	G _C (dB)	P1dB (dBm)	IIP3 (dBm)	NF (dB)
3.3	Open	202	8.3	11.0	27.3	9.8
	1k	202	7.1	11.8	27.5	9.8
5	Open	209	8.1	14.6	28.0	10.0

The IFBA pin (Pin 20) is available for reducing the DC current consumption of the IF amplifier, at the expense of IIP3. The nominal DC voltage at Pin 20 is 2.1V, and this pin should be left open-circuited for optimum performance. The internal bias circuit produces a 4mA reference for the IF amplifier, which causes the amplifier to draw approximately 101mA. If resistor R1A is connected to Pin 20 as shown in Figure 7, a portion of the reference current can be shunted to ground, resulting in reduced IF amplifier current. For example, R1A = 1k will shunt away 1.5mA from Pin 20 and the IF amplifier current will be reduced by 25% to approximately 75.5mA. Table 5 summarizes RF performance versus IF amplifier current.

Table 5. Mixer Performance with Reduced IF Amplifier Current RF = 1950MHz. High Side LO. IF = 190MHz. Vcc = VccrF = 3.3V

R1	I _{CCIF} (mA)	G _C (dB)	IIP3 (dBm)	P1dB (dBm)	NF (dB)
Open	202	8.7	25.4	10.6	9.8
4.7kΩ	184	8.5	25.2	10.8	9.8
2.2kΩ	170	8.4	24.8	10.9	9.7
1kΩ	151	8.1	24.4	11.1	9.8

RF = 2350MHz	, Low Side LC	, IF = 190MHz,	, $V_{CC} = V_{CCIF} = 3.3V$
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R1	I _{CCIF} (mA)	G _C (dB)	IIP3 (dBm)	P1dB (dBm)	NF (dB)
Open	202	8.3	27.3	11.0	9.8
4.7kΩ	184	8.1	26.8	11.2	9.8
2.2kΩ	170	8.0	26.2	11.2	9.8
1kΩ	151	7.7	25.4	11.3	9.8

Low Power Mode

Both mixer channels can be set to low power mode using the I_{SEL} pin. This allows flexibility to select a reduced current mode of operation when lower RF performance is acceptable, reducing power consumption by 37%. Figure 12 shows a simplified schematic of the I_{SEL} pin interface. When I_{SEL} is set low (<0.3V), both channels operate at nominal DC current. When I_{SEL} is set high (>2.5V), the DC current in both channels is reduced, thus reducing power consumption. The performance in low power mode and normal power mode are compared in Table 6.



Figure 12. I_{SEL} Interface Schematic

Table 6. Performance Comparison Between Different Power Modes RF = 1950MHz, High Side LO, IF = 190MHz, $V_{CC} = V_{CCIF} = 3.3V$

I _{SEL}	I _{total} (mA)	G _C (dB)	IIP3 (dBm)	P1dB (dBm)	NF (dB)
Low	401	8.7	25.4	10.6	9.8
High	252	7.4	21.2	10.9	10.2

RF = 2350MHz, Low Side LO	, IF = 190MHz,	$V_{CC} = V_{CCIF} = 3.3V$
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I _{SEL}	I _{total} (mA)	G _C (dB)	IIP3 (dBm)	P1dB (dBm)	NF (dB)	
Low	401	8.3	27.3	11.0	9.8	
High	252	7.1	22.3	11.3	10.2	



Enable Interface

Figure 13 shows a simplified schematic of the ENA pin interface (ENB is identical). To enable channel A, the ENA voltage must be greater than 2.5V. If the enable function is not required, the enable pin can be connected directly to V_{CC} . The voltage at the enable pin should never exceed the power supply voltage (V_{CC}) by more than 0.3V. If this should occur, the supply current could be sourced through the ESD diode, potentially damaging the IC.



Figure 13. ENA Interface Schematic

The Enable pins must be pulled high or low. If left floating, the on/off state of the IC will be indeterminate. If a three-state condition can exist at the enable pins, then a pull-up or pull-down resistor must be used.

Supply Voltage Ramping

Fast ramping of the supply voltage can cause a current glitch in the internal ESD protection circuits. Depending on the supply inductance, this could result in a supply voltage transient that exceeds the maximum rating. A supply voltage ramp time of greater than 1ms is recommended.

Spurious Output Levels

Mixer spurious output levels versus harmonics of the RF and LO are tabulated in Tables 7 and 8 for frequencies up to 10GHz. The spur levels were measured on a standard evalution board using the test circuit shown in Figure 1. The spur frequencies can be calculated using the following equation:

$$f_{SPUR} = (M \bullet f_{RF}) - (N \bullet f_{LO})$$

Table 7. IF Output Spur Levels (dBc), High Side LO
$(RF = 1950MHz, P_{RF} = -3dBm, P_{L0} = 0dBm, V_{CC} = V_{CCIF} = 3.3V, T_{C} = 25^{\circ}C)$

						N					
		0	1	2	3	4	5	6	7	8	9
	0	-	-45.2	-46.9	-68.4	-70.8	-75.3	-72.0	-82.0		
	1	-51.0	0	-64.4	-54.5	-68.1	-66.3	-74.9	-72.2		
	2	-80.0	-80.9	-60.6	*	-81.4	*	*	*	*	
	3	*	-83.5	*	-75.8	*	*	*	*	*	*
м	4	*	*	*	*	*	*	*	*	*	*
IVI	5	*	*	*	*	*	*	*	*	*	*
	6	*	*	*	*	*	*	*	*	*	*
	7	*	*	*	*	*	*	*	*	*	*
	8		*	*	*	*	*	*	*	*	*
	9			*	*	*	*	*	*	*	*
	10				*	*	*	*	*	*	*

*Less than –90dBc

Table 8. IF Output Spur Levels (dBc), Low Side LO
$(RF = 2350MHz, P_{BF} = -3dBm, P_{1,0} = 0dBm, V_{CC} = V_{CCIF} = 3.3V, T_{C} = 25^{\circ}C)$

	N										
		0	1	2	3	4	5	6	7	8	9
	0	-	-44.9	-46.2	-69.9	-69.7	-78.0	-71.9			
	1	-50.7	0	-63.1	-45.7	-67.0	-68.9	-71.1	-72.2	*	
	2	-77.8	-78.7	-66.5	*	-89.1	*	*	*	*	*
	3	*	*	*	-70.1	*	*	*	*	*	*
М	4	*	*	*	*	*	*	*	*	*	*
IVI	5	*	*	*	*	*	*	*	*	*	*
	6	*	*	*	*	*	*	*	*	*	*
	7		*	*	*	*	*	*	*	*	*
	8			*	*	*	*	*	*	*	*
	9				*	*	*	*	*	*	*
	10					*	*	*	*	*	*

*Less than -90dBc

PACKAGE DESCRIPTION

Please refer to http://www.linear.com/designtools/packaging/ for the most recent package drawings.



6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE



REVISION HISTORY

REV	DATE	DESCRIPTION	PAGE NUMBER			
Α	08/13	3/13 Changed LO lower frequency range from 1.7GHz to 1.5GHz.				
		LO Input Frequency Range: changed lower frequency from 1700MHz to 1500MHz.	3			
		RF Input Frequency Range, Low Side LO: changed lower frequency from 1900MHz to 1600MHz.	3			
		Updated "Conversion Gain and IIP3 vs RF Frequency" and "SSB NF vs RF Frequency" plots to include 1500MHz frequency characteristics.	5			
		Updated "LO Leakage vs LO Frequency" plot to include 1500MHz frequency characteristics.	6			
		Updated "Conversion Gain and IIP3 vs RF Frequency" and "SSB NF vs RF Frequency" plots to include 1500MHz frequency characteristics.	7			
		Pin Functions section RFA, RFB (Pins 1, 6): Changed LO input source lower frequency from 1.7GHz to 1.5GHz.	9			
		Right column, last paragraph. Deleted sentence: "These LO frequencies correspond to lower, middle and upper values in the LO range."	12			
		Figure 6, updated the LO Input Return Loss plot to include 1300MHz frequency characteristics.	13			



TYPICAL APPLICATION





RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENTS
Infrastructure)	
LTC5569	300MHz to 4GHz, 3.3V Dual Active Downconverting Mixer	2dB Gain, 26.7dBm IIP3 and 11.7dB NF at 1950MHz, 3.3V/180mA Supply
LT5557	400MHz to 3.8GHz, 3.3V Downconverting Mixer	2.9dB Gain, 24.7dBm IIP3 and 11.7dB NF at 1950MHz, 3.3V/82mA Supply
LTC6416	2GHz 16-Bit ADC Buffer	40.25dBm OIP3 to 300MHz, Programmable Fast Recovery Output Clamping
LTC6412	31dB Linear Analog VGA	35dBm OIP3 at 240MHz, Continuous Gain Range –14dB to 17dB
LTC554x	600MHz to 4GHz Downconverting Mixer Family	8dB Gain, >25dBm IIP3, 10dB NF, 3.3V/200mA Supply
LT5554	Ultralow Distort IF Digital VGA	48dBm OIP3 at 200MHz, 2dB to 18dB Gain Range, 0.125dB Gain Steps
LT5578	400MHz to 2.7GHz Upconverting Mixer	27dBm OIP3 at 900MHz, 24.2dBm at 1.95GHz, Integrated RF Transformer
LT5579	1.5GHz to 3.8GHz Upconverting Mixer	27.3dBm OIP3 at 2.14GHz, NF = 9.9dB, 3.3V Supply, Single-Ended LO and RF Ports
RF Power De	tectors	
LT5581	6GHz Low Power RMS Detector	40dB Dynamic Range, ±1dB Accuracy Over Temperature, 1.5mA Supply Current
LTC5582	10GHz RMS Power Detector	40MHz to 10GHz, Up to 57dB Dynamic Range, ±0.5dB Accuracy Over Temperature
LTC5583	Dual 6GHz RMS Power Detector	40MHz to 6GHz, Up to 60dB Dynamic Range, >40dB Channel-to-Channel Isolation
ADCs	·	
LTC2285	14-Bit, 125Msps Dual ADC	72.4dB SNR, >88dB SFDR, 790mW Power Consumption
LTC2185	16-Bit, 125Msps Dual ADC Ultralow Power	74.8dB SNR, 185mW/Channel Power Consumption
LTC2242-12	12-Bit, 250Msps ADC	65.4dB SNR, 78dB SFDR, 740mW Power Consumption



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